

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10584212	YUAN ET AL.
	<b>Examiner</b>	<b>Art Unit</b>
	ZEWDU BEYEN	2461

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
370	401.389.392(updated text only)	20090830	zb

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
I did inventor search using PALM	20090830	ZB
Database searched --EAST (US- PGPUB,USPAT,FPRS,EPO,JPO,DERWENT)		ZB

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>

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